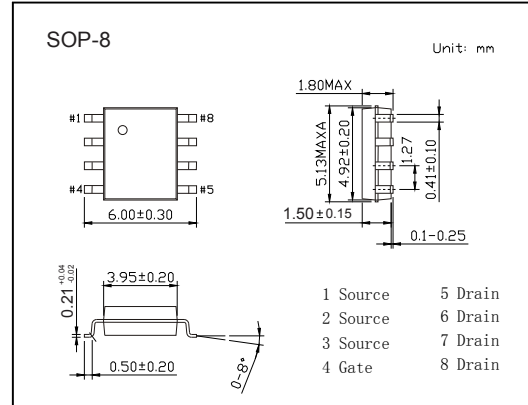
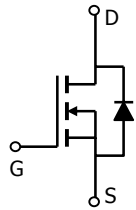


## N-Channel MOSFET

### AO4468 (KO4468)

#### ■ Features

- $V_{DS} (V) = 30V$
- $I_D = 10.5 A (V_{GS} = 10V)$
- $R_{DS(ON)} < 17m\Omega (V_{GS} = 10V)$
- $R_{DS(ON)} < 23m\Omega (V_{GS} = 4.5V)$



#### ■ Absolute Maximum Ratings $T_a = 25^\circ C$

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current	$I_D$	$T_A=25^\circ C$	A
		$T_A=70^\circ C$	
Pulsed Drain Current	$I_{DM}$	50	
Avalanche Current	$I_{AS}, I_{AR}$	19	
Power Dissipation	$P_D$	$T_A=25^\circ C$	W
		$T_A=70^\circ C$	
Avalanche energy	$L=0.1mH$	$E_{AS}, E_{AR}$	mJ
Thermal Resistance.Junction- to-Ambient	$R_{thJA}$	$t \leq 10s$	$^\circ C/W$
		Steady-State	
Thermal Resistance.Junction- to-Lead	$R_{thJC}$	24	
Junction Temperature	$T_J$	150	$^\circ C$
Storage Temperature Range	$T_{stg}$	-55 to 150	

## N-Channel MOSFET

## AO4468 (KO4468)

## ■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit	
Drain-Source Breakdown Voltage	V <sub>DSS</sub>	I <sub>D</sub> =250 μA, V <sub>GS</sub> =0V	30			V	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	μA	
		V <sub>DS</sub> =30V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C			5		
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =±16V			±10	μA	
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =10 mA	1.2		2.4	V	
Static Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =10.5A			17	mΩ	
		V <sub>GS</sub> =10V, I <sub>D</sub> =10.5A, T <sub>J</sub> =125°C			24		
		V <sub>GS</sub> =5V, I <sub>D</sub> =9A			23		
On State Drain Current	I <sub>D(ON)</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =5V	50			A	
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =5V, I <sub>D</sub> =10.5A		36		S	
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz			888	pF	
Output Capacitance	C <sub>oss</sub>				145		
Reverse Transfer Capacitance	C <sub>rss</sub>				115		
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	0.5		1.7	Ω	
Total Gate Charge (10V)	Q <sub>g</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =10.5A		15		nC	
Total Gate Charge (4.5V)				7.5			
Gate Source Charge			Q <sub>gs</sub>		2.5		
Gate Drain Charge			Q <sub>gd</sub>		3		
Turn-On DelayTime	t <sub>d(on)</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =1.45Ω, R <sub>G</sub> =3Ω		5		ns	
Turn-On Rise Time	t <sub>r</sub>			3.5			
Turn-Off DelayTime	t <sub>d(off)</sub>			19			
Turn-Off Fall Time	t <sub>f</sub>			3.5			
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =10.5A, di/dt=100A/μs			22	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>				12		nC
Maximum Body-Diode Continuous Current	I <sub>S</sub>				4	A	
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			1	V	

## ■ Marking

Marking	4468 KC****
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## N-Channel MOSFET AO4468 (KO4468)

■ Typical Characteristics

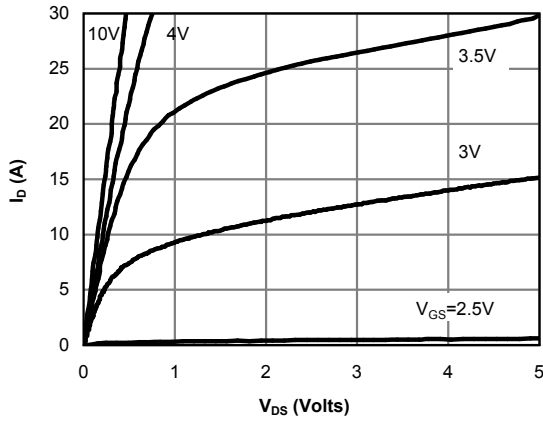


Fig 1: On-Region Characteristics (Note E)

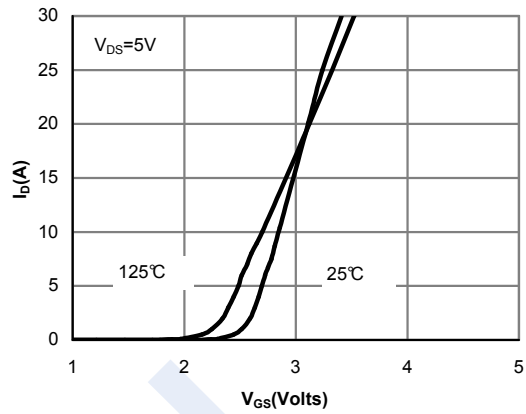


Figure 2: Transfer Characteristics (Note E)

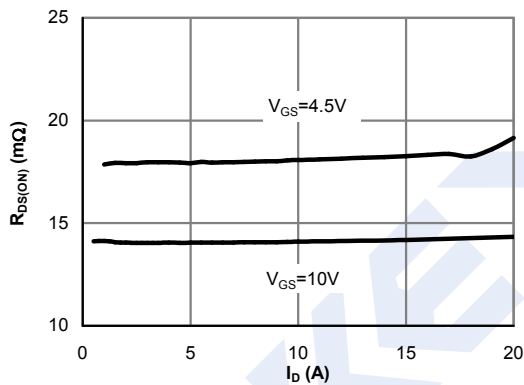


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

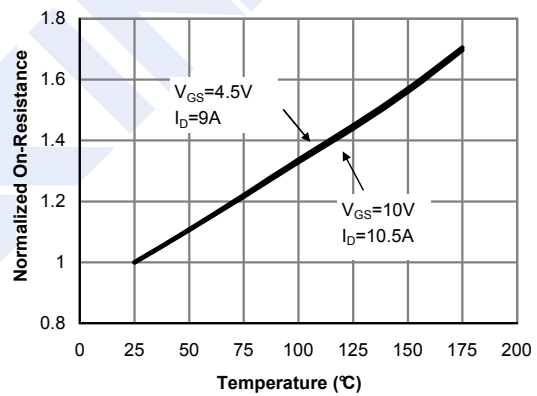


Figure 4: On-Resistance vs. Junction Temperature (Note E)

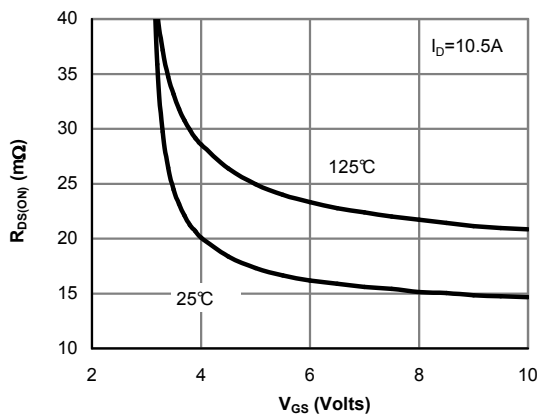


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

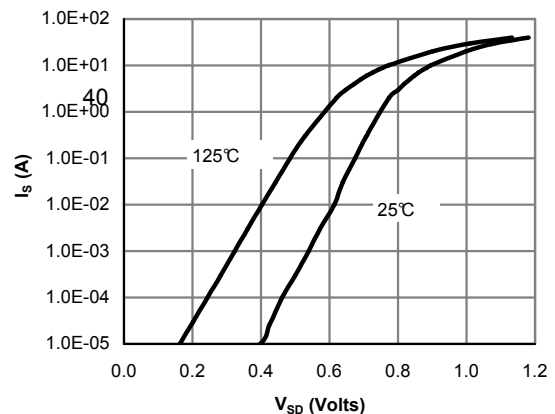


Figure 6: Body-Diode Characteristics (Note E)

## N-Channel MOSFET AO4468 (KO4468)

■ Typical Characteristics

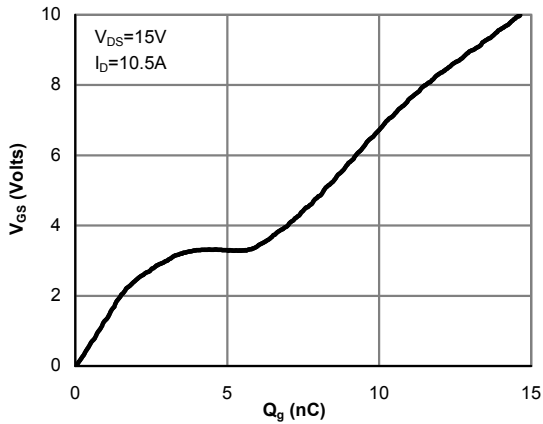


Figure 7: Gate-Charge Characteristics

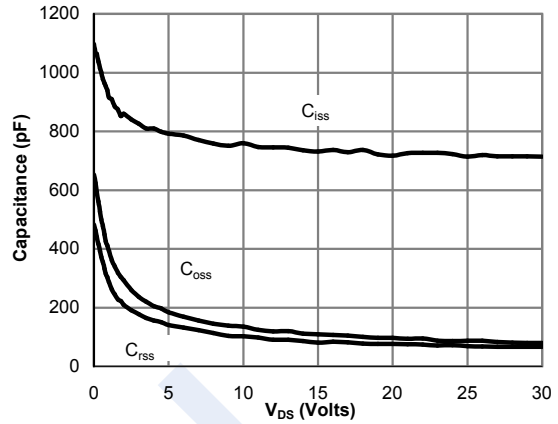


Figure 8: Capacitance Characteristics

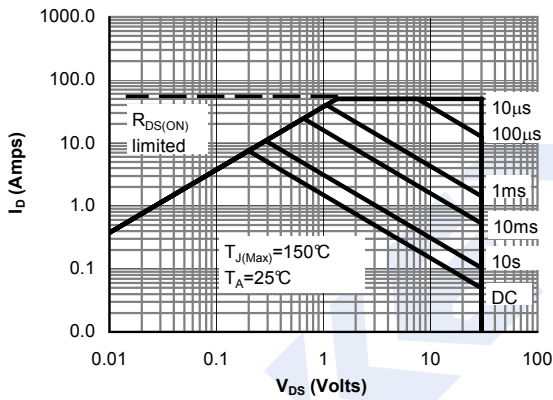


Figure 10: Maximum Forward Biased Safe Operating Area (Note F)

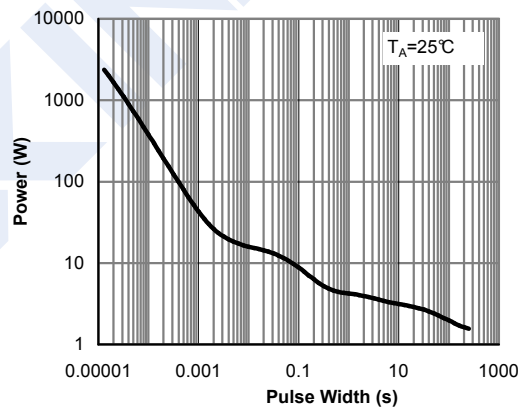


Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)

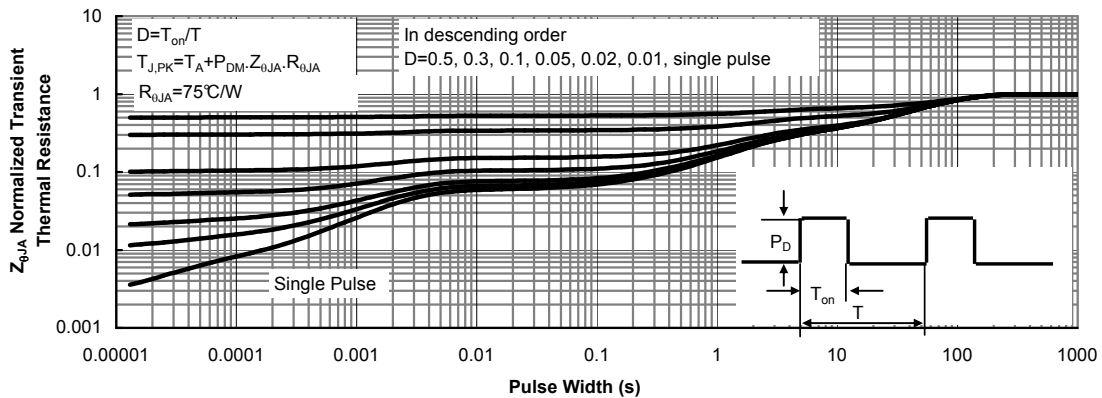


Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)